FQA19N20

200V N-Channel MOSFET

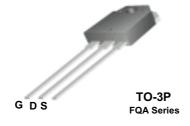
General Description

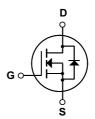
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply, DC-AC converters for uninterrupted power supply, motor control.

Features

- 23A, 200V, $R_{DS(on)}$ = 0.15 Ω @V_{GS} = 10 V Low gate charge (typical 31 nC)
- Low Crss (typical 30 pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQA19N20	Units
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C	C)	23	Α
	- Continuous (T _C = 100°C)		14.5	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	92	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	250	mJ
I _{AR}	Avalanche Current	(Note 1)	23	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	19	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P _D	Power Dissipation (T _C = 25°C)		190	W
	- Derate above 25°C		1.52	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.66	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

•	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	200			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.18		V/°C
DSS 7	Zoro Cata Valtaga Desir Coment	V _{DS} = 200 V, V _{GS} = 0 V			1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 160 V, T _C = 125°C		-	10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V		-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 11.5 A		0.12	0.15	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 11.5 A (Note 4)		16		S
		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		1220	1600	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		220	290	рF
C _{oss}	Output Capacitance Reverse Transfer Capacitance					•
C _{rss}	' ' '			220	290	pF
C _{rss}	Reverse Transfer Capacitance	f = 1.0 MHz		220	290	pF
C _{rss} Switch	Reverse Transfer Capacitance	f = 1.0 MHz V _{DD} = 100 V, I _D = 19.4 A,		220 30	290 40	pF pF
Switch	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time	f = 1.0 MHz $V_{DD} = 100 \text{ V}, I_D = 19.4 \text{ A},$ $R_G = 25 \Omega$		220 30 20	290 40 50	pF pF
$\begin{array}{c} \textbf{C}_{\text{rss}} \\ \\ \textbf{Switch} \\ \\ \textbf{t}_{\text{d(on)}} \\ \\ \textbf{t}_{\text{r}} \\ \\ \\ \textbf{t}_{\text{d(off)}} \\ \\ \textbf{t}_{\text{f}} \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time	f = 1.0 MHz V _{DD} = 100 V, I _D = 19.4 A,		220 30 20 190	290 40 50 390	pF pF
$\begin{array}{c} \mathbf{C}_{rss} \\ \hline \mathbf{Switch} \\ \mathbf{t}_{d(on)} \\ \mathbf{t}_{r} \\ \mathbf{t}_{d(off)} \\ \mathbf{t}_{f} \\ \mathbf{Q}_{g} \\ \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	f = 1.0 MHz $V_{DD} = 100 \text{ V}, I_D = 19.4 \text{ A},$ $R_G = 25 \Omega$		220 30 20 190 55	290 40 50 390 120	pF pF ns ns
$\begin{array}{c} \textbf{C}_{\text{rss}} \\ \\ \textbf{Switch} \\ \\ \textbf{t}_{\text{d(on)}} \\ \\ \textbf{t}_{\text{r}} \\ \\ \\ \textbf{t}_{\text{d(off)}} \\ \\ \textbf{t}_{\text{f}} \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	f = 1.0 MHz V_{DD} = 100 V, I_{D} = 19.4 A, R_{G} = 25 Ω (Note 4, 5)		220 30 20 190 55 80	290 40 50 390 120 170	pF pF ns ns
$\begin{array}{c} \mathbf{C}_{rss} \\ \hline \mathbf{Switch} \\ \mathbf{t}_{d(on)} \\ \mathbf{t}_{r} \\ \mathbf{t}_{d(off)} \\ \mathbf{t}_{f} \\ \mathbf{Q}_{g} \\ \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 100 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 160 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$	 	220 30 20 190 55 80 31	290 40 50 390 120 170 40	pF pF ns ns ns
$\begin{array}{c} \textbf{C}_{rss} \\ \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 100 \text{ V}, I_{D} = 19.4 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 160 \text{ V}, I_{D} = 19.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5)	 	220 30 20 190 55 80 31 8.6	290 40 50 390 120 170 40	pF pF ns ns ns ns
$\begin{array}{c} \textbf{C}_{\text{rss}} \\ \textbf{Switch} \\ \textbf{t}_{\text{d(on)}} \\ \textbf{t}_{\text{r}} \\ \textbf{t}_{\text{d(off)}} \\ \textbf{t}_{\text{f}} \\ \textbf{Q}_{\text{g}} \\ \textbf{Q}_{\text{gs}} \\ \textbf{Q}_{\text{gd}} \\ \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 100 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $R_{G} = 25 \Omega$ $(Note 4, 5)$ $V_{DS} = 160 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ $(Note 4, 5)$ and Maximum Ratings	 	220 30 20 190 55 80 31 8.6	290 40 50 390 120 170 40	pF pF ns ns ns ns
$\begin{array}{c} \textbf{C}_{rss} \\ \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \\ \textbf{Drain-S} \\ \textbf{I}_{S} \\ \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 100 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 160 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) and Maximum Ratings are Forward Current	 	220 30 20 190 55 80 31 8.6 13.5	290 40 50 390 120 170 40 	pF pF ns ns ns ns nc nC
$\begin{array}{c} \textbf{C}_{rss} \\ \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \\ \textbf{Drain-S} \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics as Maximum Continuous Drain-Source Diode	$f = 1.0 \text{ MHz}$ $V_{DD} = 100 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 160 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) and Maximum Ratings are Forward Current		220 30 20 190 55 80 31 8.6 13.5	290 40 50 390 120 170 40 	pF pF ns ns ns nc nC
$\begin{array}{c} \textbf{C}_{rss} \\ \textbf{Switch} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \\ \textbf{Drain-S} \\ \textbf{I}_{SM} \\ \end{array}$	Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics au Maximum Continuous Drain-Source Diode F	$f = 1.0 \text{ MHz}$ $V_{DD} = 100 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 160 \text{ V}, \text{ I}_{D} = 19.4 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) $\text{Ad Maximum Ratings}$ $\text{ode Forward Current}$ Forward Current	 	220 30 190 55 80 31 8.6 13.5	290 40 50 390 120 170 40 	pF pF ns ns ns nc nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 0.7mH, I_{AS} = 23A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C 3. I_{SD} \leq 19.4A, di/dt \leq 300A/μs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300μs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

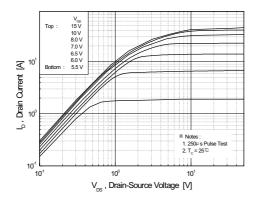


Figure 1. On-Region Characteristics

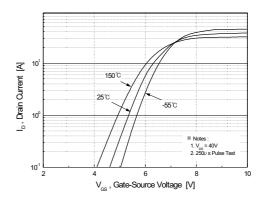


Figure 2. Transfer Characteristics

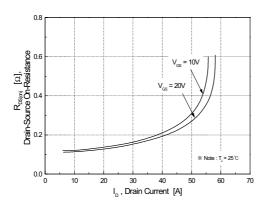


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

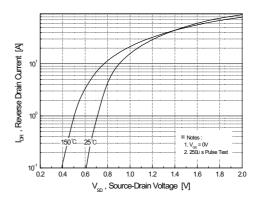


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

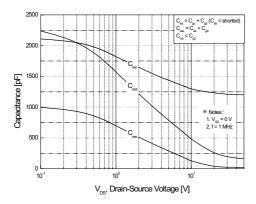


Figure 5. Capacitance Characteristics

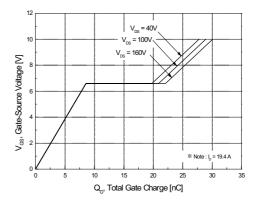
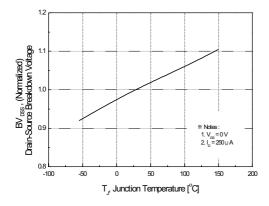


Figure 6. Gate Charge Characteristics

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Typical Characteristics (Continued)



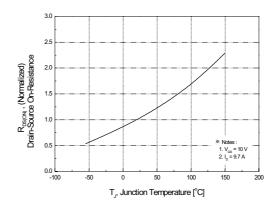
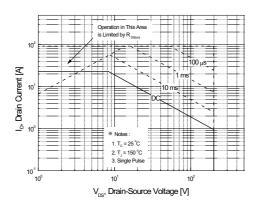


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



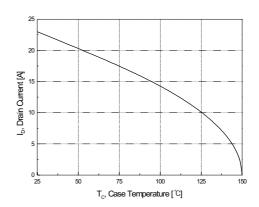


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

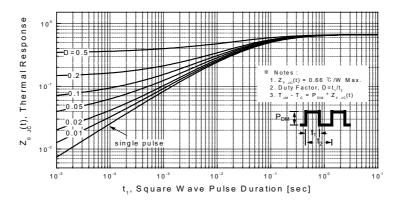
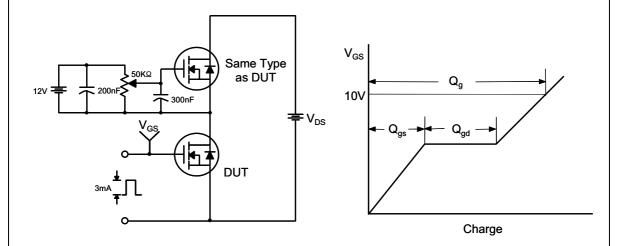


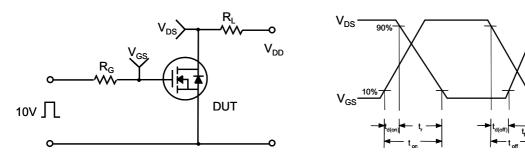
Figure 11. Transient Thermal Response Curve

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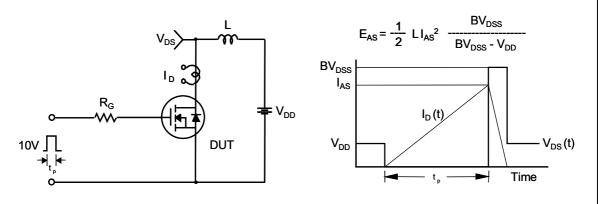
Gate Charge Test Circuit & Waveform



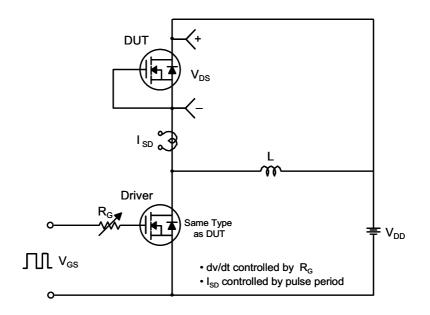
Resistive Switching Test Circuit & Waveforms

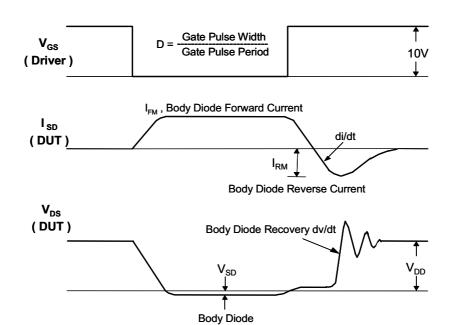


Unclamped Inductive Switching Test Circuit & Waveforms



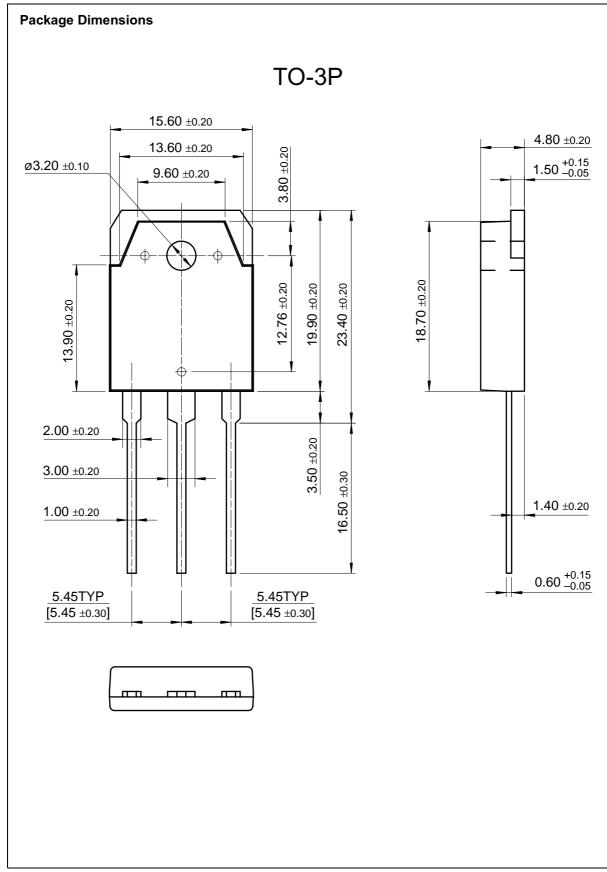
Peak Diode Recovery dv/dt Test Circuit & Waveforms





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Forward Voltage Drop



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result in significant injury to the user.

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